

# AON6458-VB Datasheet

# N-Channel 250 V (D-S) MOSFET

PRODUCT SUMMARY						
V <sub>DS</sub> (V)	250					
$R_{DS(on)}$ Typ. ( $\Omega$ ) at $V_{GS} = 10 \text{ V}$	0.042					
$R_{DS(on)}$ Typ. ( $\Omega$ ) at $V_{GS} = 7.5 \text{ V}$	0.048					
Q <sub>g</sub> typ. (nC)	20					
I <sub>D</sub> (A)	35					
Configuration	Single					

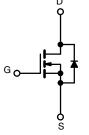
#### **FEATURES**

- ThunderFET® technology optimizes balance of  $R_{DS(\text{on})},\,Q_g,\,Q_{sw}$  and  $Q_{oss}$
- 100 % R<sub>g</sub> and UIS tested



#### **APPLICATIONS**

- · Fixed telecom
- DC/DC converter
- Primary and secondary side switch
- Synchronous rectification
- LED lighting
- Power supplies
- Class D amplifier



N-Channel MOSFET

DFN5X6					
Top View	<b>Bottom View</b>				
PIN1	(A)				

s [	1 •	8	D
s [	2	7	D
s [	3	6	D
G [	4	5	D

Top View

PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V <sub>DS</sub>	250	V	
Gate-source voltage		V <sub>GS</sub>	± 20		
	T <sub>C</sub> = 25 °C		35		
Continuous dunin suurent /T 150 °C)	T <sub>C</sub> = 70 °C		25		
Continuous drain current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	8.6 b, c		
	T <sub>A</sub> = 70 °C		6.9 <sup>b, c</sup>		
Pulsed drain current (t = 100 μs)		I <sub>DM</sub>	80	Α	
Continuous source-drain diode current	T <sub>C</sub> = 25 °C		32		
	T <sub>A</sub> = 25 °C	I <sub>S</sub>	6.5 <sup>b, c</sup>		
Single pulse avalanche current		I <sub>AS</sub>	35		
Single pulse avalanche energy	L = 0.1 mH	E <sub>AS</sub>	48	mJ	
	T <sub>C</sub> = 25 °C		109		
Maximum power dissipation	T <sub>C</sub> = 70 °C		69.6	14/	
	T <sub>A</sub> = 25 °C	P <sub>D</sub>	7.25 <sup>b, c</sup>	w	
	T <sub>A</sub> = 70 °C		5 <sup>b, c</sup>		
Operating junction and storage temperature range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150		
Soldering recommendations (peak temperature) c			260	°C	

THERMAL RESISTANCE RATINGS							
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT		
Maximum junction-to-ambient <sup>b</sup>	t ≤ 10 s	R <sub>thJA</sub>	15	20	°C/W		
Maximum junction-to-case (drain)	Steady state	R <sub>thJC</sub>	0.9	1.2	C/VV		

#### Notes

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. The DFN5x 6 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 54 °C/W.
- g.  $T_C = 25$  °C.



PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static						
Drain-source breakdown voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	250	-	-	V
V <sub>DS</sub> temperature coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = 10 mA	-	173	-	
V <sub>GS(th)</sub> temperature coefficient	$\Delta V_{GS(th)}/T_J$	I <sub>D</sub> = 250 μA	-	-7.1	-	mV/°C
Gate-source threshold voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	
Gate-source leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	-	-	100	nA
Zara maka walka sa alusin awarant		V <sub>DS</sub> = 250 V, V <sub>GS</sub> = 0 V	-	-	1	μΑ
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> = 250 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 70 °C	-	-	15	
On-state drain current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	35	-	-	Α
Dunin	Б	V <sub>GS</sub> =10 V, I <sub>D</sub> = 10 A	-	0.042	-	_
Drain-source on-state resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 7.5 \text{ V}, I_D = 10 \text{ A}$	-	0.048	-	Ω
Forward transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 15 \text{ V}, I_D = 10 \text{ A}$	-	27	-	S
Dynamic <sup>b</sup>						
Input capacitance	C <sub>iss</sub>		-	1180	-	
Output capacitance	C <sub>oss</sub>	$V_{DS} = 100 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	142	-	pF
Reverse transfer capacitance	C <sub>rss</sub>		-	11	-	
Tatal asta abassa	gate charge $Q_g = V_{DS} = 100 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 10 A	-	25	38	nC
Total gate charge			-	20	30	
Gate-source charge	Q <sub>gs</sub>	$V_{DS} = 100 \text{ V}, V_{GS} = 7.5 \text{ V}, I_D = 10 \text{ A}$	-	6.4	-	
Gate-drain charge	Q <sub>gd</sub>		-	6.8	-	
Output charge	Q <sub>oss</sub>	V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V	-	52	-	1
Gate resistance	$R_g$	f = 1 MHz	0.6	2.1	4	Ω
Turn-on delay time	t <sub>d(on)</sub>		-	9	18	
Rise time	t <sub>r</sub>	$V_{DD} = 100 \text{ V}, R_{I} = 10 \Omega, I_{D} \cong 10 \text{ A},$	-	20	40	
Turn-off delay time	t <sub>d(off)</sub>	$V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	20	40	
Fall time	t <sub>f</sub>		-	24	48	
Turn-on delay time	t <sub>d(on)</sub>		-	11	22	ns
Rise time	t <sub>r</sub>	$V_{DD}$ = 100 V, $R_L$ = 10 $\Omega$ , $I_D \cong$ 10 A,	-	27	54	7
Turn-off delay time	t <sub>d(off)</sub>	$V_{GEN}$ = 7.5 V, $R_g$ = 1 $\Omega$	-	18	36	
Fall time	t <sub>f</sub>		-	24	48	
Drain-Source Body Diode Characteristi	cs					
Continuous source-drain diode current	I <sub>S</sub>	T <sub>C</sub> = 25 °C	-	-	35.4	٨
Pulse diode forward current	I <sub>SM</sub>		_	_	80	A
Body diode voltage	V <sub>SD</sub>	I <sub>S</sub> = 5 A, V <sub>GS</sub> = 0 V	-	0.77	1.1	V
Body diode reverse recovery time	t <sub>rr</sub>		-	100	200	ns
Body diode reverse recovery charge	Q <sub>rr</sub>	1 10 A dl/d+ 100 A/ T 05 00	-	400	800	nC
Reverse recovery fall time	ta	$I_F = 10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$	-	80	-	,
Reverse recovery rise time	t <sub>b</sub>		-	20	-	ns

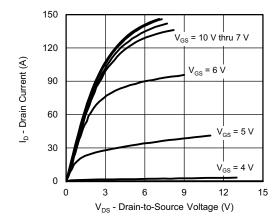
#### Notes

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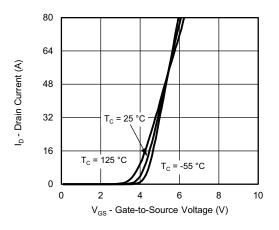
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

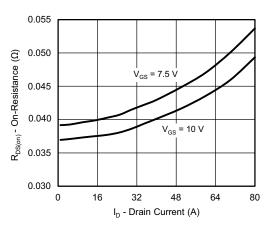




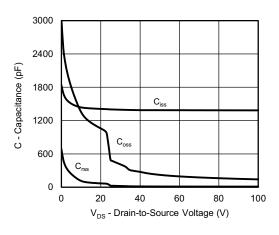
**Output Characteristics** 



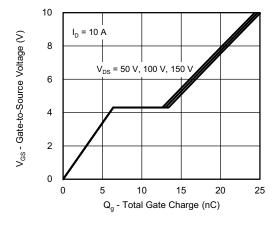
**Transfer Characteristics** 



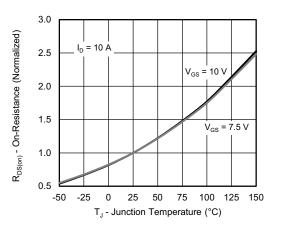
On-Resistance vs. Drain Current and Gate Voltage



Capacitance

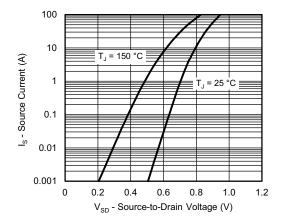


**Gate Charge** 

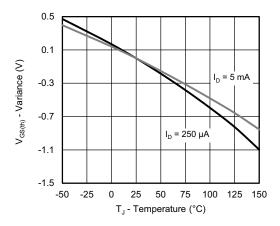


On-Resistance vs. Junction Temperature

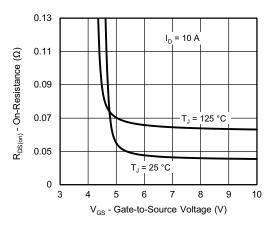




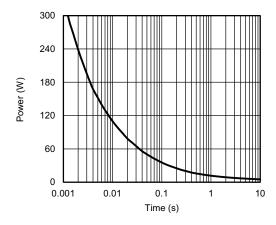
Source-Drain Diode Forward Voltage



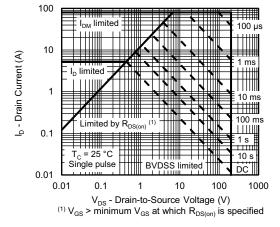
**Threshold Voltage** 



On-Resistance vs. Gate-to-Source Voltage

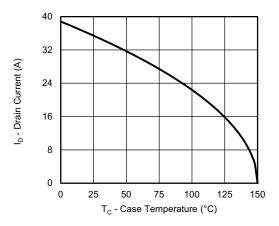


Single Pulse Power, Junction-to-Ambient

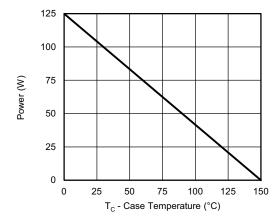


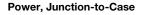
Safe Operating Area, Junction-to-Ambient

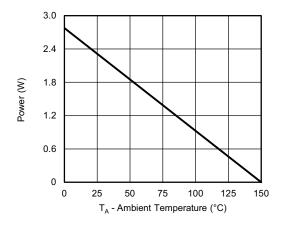




#### Current Derating a





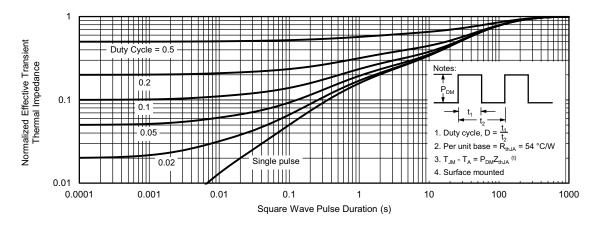


Power, Junction-to-Ambient

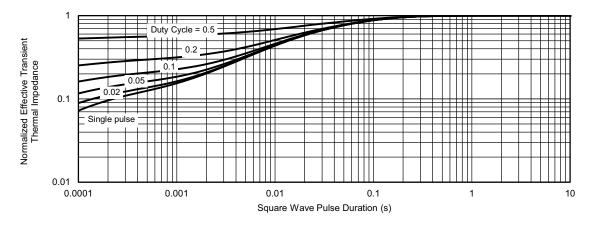
#### Note

a. The power dissipation P<sub>D</sub> is based on T<sub>J</sub> max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





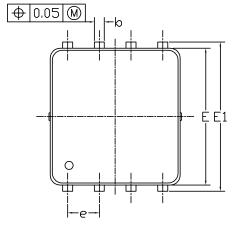
Normalized Thermal Transient Impedance, Junction-to-Ambient

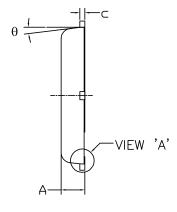


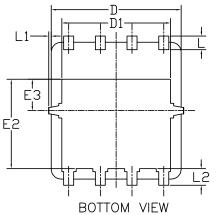
Normalized Thermal Transient Impedance, Junction-to-Case

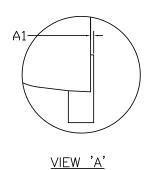


# DFN5x6\_8L\_EP1\_P PACKAGE OUTLIN



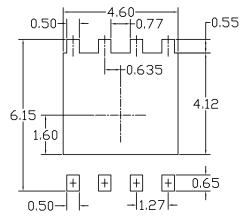






(SCALE 5:1)

#### RECOMMENDED LAND PATTERN



SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHES		
S I MBOLS	MIN	NOM	MAX	MIN	NOM	MAX
A	0.85	0. 95	1.00	0.033	0.037	0.039
A1	0.00		0.05	0.000		0.002
b	0.30	0.40	0.50	0.012	0.016	0.020
c	0.15	0. 20	0. 25	0.006	0.008	0.010
D	5. 10	5. 20	5. 30	0. 201	0. 205	0. 209
D1	4. 25	4. 35	4. 45	0.167	0.171	0. 175
Е	5. 45	5. 55	5. 65	0. 215	0. 219	0. 222
E1	5. 95	6.05	6. 15	0. 234	0. 238	0. 242
E2	3. 525	3. 625	3. 725	0.139	0. 143	0. 147
E3	1. 175	1. 275	1. 375	0.046	0.050	0.054
e		1.27 BSC		0.050 BSC		
L	0.45	0. 55	0.65	0.018	0.022	0.026
L1	0		0.15	0		0.006
L2	0. 68 REF			0. 027 REF		
θ	0°		10°	0°		10°

#### NOTE

- UNIT: mm
- 1. PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS. MOLD FLASH AT THE NON-LEAD SIDES SHOULD BE LESS THAN 6 MILS EACH.
- 2. CONTROLLING DIMENSION IS MILLIMETER. CONVERTED INCH DIMENSIONS ARE NOT NECESSARILY EXACT.



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